

## Notice of References Cited

Application/Control No.

O9/653,411

Examiner

Joseph Nguyen

Applicant(s)/Patent Under Reexamination
LEE ET AL.

Art Unit
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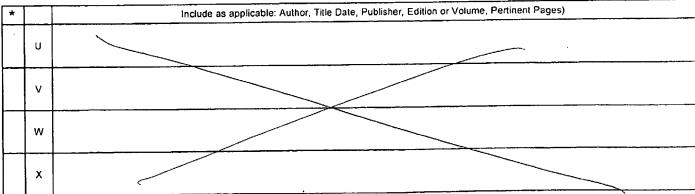
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## NON-PATENT DOCUMENTS



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